

**Search Notes**

Application/Control No.

10/615,287

Examiner

H.Jey Tsai

Applicant(s)/Patent under  
Reexamination

PAREKH ET AL.

Art Unit

2812

**SEARCHED**

Class	Subclass	Date	Examiner
438	238, 253- 256, 381, 3, 240	2/1/2005	j
438	396-399	2/1/2005	J

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
438	253	2/1/2005	J

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR